


<b>Search Notes</b>  	<b>Application/Control No.</b>  10573671	<b>Applicant(s)/Patent Under Reexamination</b>  HILL ET AL.
	<b>Examiner</b>  Ellen Kim	<b>Art Unit</b>  2874

SEARCHED			
Class	Subclass	Date	Examiner
385	141, 12	5/11/09	EK
436	164	5/11/09	EK

SEARCH NOTES		
Search Notes	Date	Examiner
East	5/11/09	EK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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